Application/Control No. Applicant(s)/Patent Under Reexamination 10/670,545 HSIEH ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Alford W. Kindred 2163 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY 04-2004 US-2004/0064351 Mikurak, Michael G. 705/007 Α В US-US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ν

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